Search Notes				

	Application/Control No.	Applicant(s)/Patent under Reexamination	
	09/825,912	SMITH ET AL.	
ſ	Examiner	Art Unit	
	Steven S. Paik	2876	

	SEAR	CHED	
Class	Subclass	Date	Examiner
235	379		
	382		
updated		12/24/2005	SSP

INTERFERENCE SEARCHED		
Subclass	Date	Examiner
above	12/24/2005	SSP
	Subclass	Subclass Date above 12/24/2005

SEARCH (INCLUDING SEA)
	DATE	EXMR
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Text search 235/375;382.5;383 705/16;30		
updated	12/24/2005	SSP
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